

Specification number:EQM08-1KC-E175K16

Date of issue: 16 May, 2017

Multilayer ceramic Chip capacitor specification

Product Part No

CT05X5R225M06AH033

(Recipient stamp column)

Please send back with recipient stamp or signature here.

This specification would be invalidated unless sent back within a year after issue date of this specification.

RoHS Compliant

Kyocera Corporation
Capacitor Division



No.	Date	Contents	PREPD.	CHKD.	CHKD.	APPD.
1	2017/05/16	NEW				



[Part No]

Characteristic	K/C Supplier Part No	Remarks
X5R	CT05X5R225M06AH033	



1.Scope

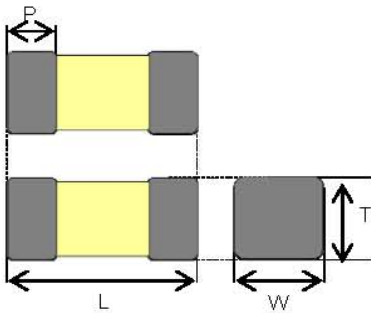
This specification sheet shall be applied to multilayer ceramic chip capacitors;Kyocera CT series.

2.Nomenclature

CT □□ □□ □□□ □ □□ △ □ □□□
 Series (1) (2) (3) (4) (5) (6) (7) (8)

- (1) : Size
- (2) : Temperature Characteristics
- (3) : Capacitance
- (4) : Tolerance
- (5) : Rated Voltage
- (6) : External Electrode
- (7) : Packaging
- (8) : Thickness max

(1)External Dimensions(Size)



External Dimension for Taping or Bulk (unit:mm)

Type	L	W	T	P
05	1.00±0.05	0.50±0.05	0.33 max	0.15~0.35

(2)Temperature Characteristics

Characteristics	Applied voltage	Change in capacitance	Operating temperature range	Reference
X5R	No applied voltage	Within +/- 15%	-55°C~+85°C	25°C



(3)Capacitance Value

Capacitance is indicated by three numbers and a letter (see example as follows).
The first and second digits indicate the first two significant figures, and the final digit is a base 10 logarithmic multiplier in picofarads.

(Ex.)

Code	Capacitance
225	2,200,000pF

(4)Tolerance

Code	M
Tolerance	±20%

(5)Rated Voltage

Code	06
Voltage	6.3Vdc

(6)Termination (External Electrode)

A: Nickel Barrier/ Tin

(7)Packaging Configuration

Code	Packaging Configuration	Applying Size
H	Taping(2mm Pitch. ϕ 180 Reel)	Refer to Taping specification

(8)Thickness max

033 : 0.33mm max.

3.Operating temperature range

Refer to Item 2-(2)



4.Specifications and Test Methods

(Table 1-1)

Item	Specification		Measuring Conditions
	X5R		
Temperature Characteristics	Refer to Item 2-(2)		High Temperature Treatment (Table 2) C≤10μF Measuring frequency 1kHz±10% Measuring voltage Refer to (Table 3)
Capacitance	Within specified tolerance value		
tanδ	Refer to (Table 3)		
(*1)Insulation Resistance	Refer to (Table 3)		Measure after charging with the rated voltage within 1 minutes at room conditions.
(*1)Dielectric Strength	No problem observed		Applying 2.5 times of the rated voltage for 1 to 5 seconds.
Appearance	No serious defect		Under Microscope
Resistance to Vibration	Appearance	No serious defect	Perform High Temperature Treatment (Table 2) , then measure the initial capacitance and tanδ. Vibration frequency:10 to 55 (Hz) Swing width :1.5mm Sweep :10→55→10 Hz/1min x,y,z axis 2 hours/each Total 6 hours (Refer to Fig.1)
	Capacitance Variation	Within specified tolerance value	
	tanδ	Satisfies initial specified value	
Resistance to Solder Leaching	Appearance	No serious defect	Perform High Temperature Treatment (Table 2) , then measure the initial capacitance and tanδ. After dipped molten solder, at 260±5°C for 10±0.5 seconds and kept at room conditions for 24±2 hours, measure and check the specifications. *Pre-heat before immersion 1st: 80°C to 100°C for 120sec. 2st:150°C to 200°C for 120sec.
	Capacitance Variation	Within ±7.5%	
	tanδ	Satisfies initial specified value	
	(*1)Insulation Resistance	Within specified tolerance value	
	(*1)Dielectric Strength	Resist without problem.	
Solderability	Coverage >= 90% Each termination end		Soaking Condition <Sn-3Ag-0.5Cu> 245±5°C 3±0.5sec. <Sn63 Solder> 235±5°C 2±0.5sec.

(Table 1-2)

Item		Specification	Measuring Conditions
		X5R	
Temperature Cycling	Appearance	No serious defect	Perform High Temperature Treatment (Table 2) , then measure the initial capacitance and tan δ . <Cycle> Room temperature (3 minutes) - Lowest operating temperature (30 minutes) – Room temperature (3 minutes) – Highest operating temperature (30 minutes). After 5 cycles of the above, keep for after 24 \pm 2 hours at room conditions then measure. (Refer to Fig.2)
	Capacitance Variation	Refer to (Table 4)	
	tan δ	Satisfies initial specified value	
	(*1)Insulation Resistance	Refer to (Table 4)	
	(*1)Dielectric Strength	Resist without problem	
Load Humidity Resistance	Appearance	No serious defect	Perform Voltage Treatment (Table 2) , then measure the initial capacitance and tan δ . After applying rated voltage for 500+12/-0 hours in pre-condition at 40 \pm 2 $^{\circ}$ C, humidity 90% to 95%RH, allow parts to stabilize for 24 \pm 2 hours, at room temperature before measurement.
	Capacitance Variation	Refer to (Table 4)	
	tan δ	Less than 2 times of the initial value	
	(*1)Insulation Resistance	Refer to (Table 4)	
High Temperature Life Test	Appearance	No serious defect	Perform Voltage Treatment (Table 2) , then measure the initial capacitance and tan δ . After applying voltage (Magnification of Applied voltage \times Rated voltage) for 1000+12/-0 hours in pre-condition at the highest temperature, allow parts to stabilize for 24 \pm 2 hours, at room temperature before measurement. * Magnification of Applied voltage: refer to (Table 4)
	Capacitance Variation	Refer to (Table 4)	
	tan δ	Less than 2 times of the initial value	
	(*1)Insulation Resistance	Refer to (Table 4)	

(*1) Insulation Resistance/Dielectric Strength;Charging or discharging current for these tests Is limited under 50mA.

(Table 2)

Initial Treatment	High Temperature Treatment	Keep chip capacitor at 150 $^{\circ}$ C +0/-10 $^{\circ}$ C for 1 hour,Then leave chip capacitor at room temperature and normal humidity for 24 \pm 2 hours.
	Voltage Treatment	Pretreat capacitor for 1 hour at the same condition of the load test, Then leave them at room condition for 24 \pm 2 hours before beginning the Load test.

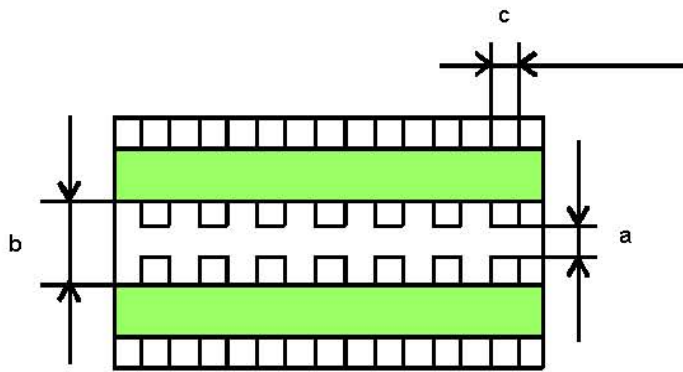


[Table3 Parts List]

Product Part No	Dimension [mm]			tanδ [%]max	IR (initial) min	Capacitance/ tanδ Measuring voltage	Temperature Characteristics Measuring voltage
	L	W	T				
CT05X5R225M06AH033	1.00±0.05	0.50±0.05	0.33 max.	12.5%	100MΩ•μF	1.0±0.2Vrms	0.5±0.1Vrms

[Table4 test specifications]

Product Part No	Temperature Cycling		Load Humidity Resistance		High Temperature Life Test		
	Capacitance Variation	IR (Minimum value)	Capacitance Variation	IR (Minimum value)	Voltage Bias [%]	Capacitance Variation	IR (Minimum value)
CT05X5R105M06AH022	±20.0%	20 MΩ•μF	±25.0%	10 MΩ•μF	100%	±25.0%	10 MΩ•μF

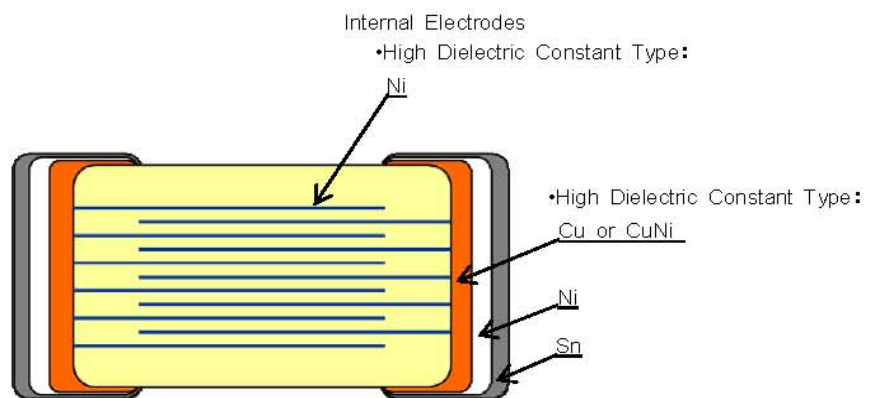


type	a	b	C
05	0.4	1.4	0.5

glass epoxy board

Fig.1 Substrate for temperature cycle test

[Structure]



[Production facility]

Kagoshima Kokubu plant



Taping Specification

1.Application

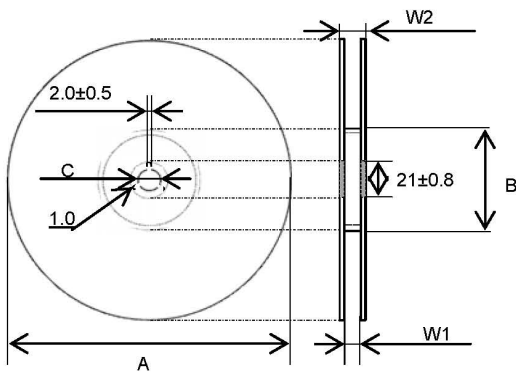
This specification applies to paper carrier tape of Kyocera multi-layer ceramic chip capacitor.

2.Packing unit

type	thickness (unit:mm)	material of carrier tape		width of carrier tape		Φ180 reel quantity per reel
		paper	Plastic	8mm	12mm	
05	0.33 max	○	-	○	-	10000

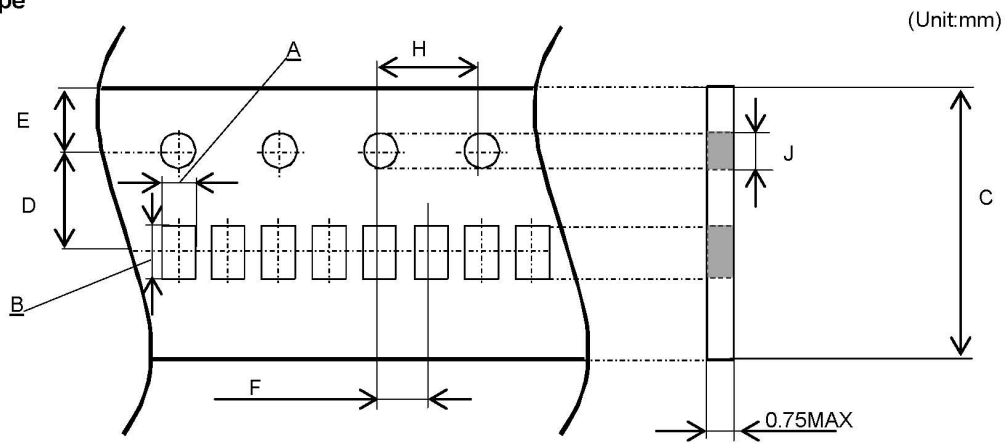
3.Shape and dimintions

(1)Reel



[Dimension]	Unit:mm		
	A	B	C
Φ180 reel (Code:H)	Φ180+0/-2.0	Φ60min	Φ13.0±0.5
	W1	W2	
Φ180 reel (Code:H)	10.0±1.5	16.5max	

(2)Carrier Tape



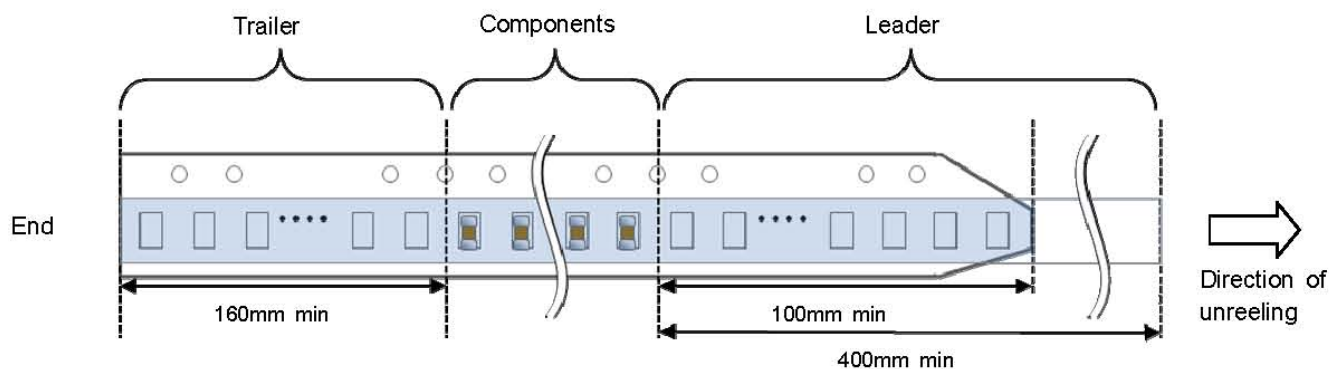
		(unit:mm)							
Code		A	B	C	D	E	F	H	J
	Tolerance	±0.1	±0.1	±0.3	±0.05	±0.1	±0.05	±0.1	+0.1/-0
Type	05	0.65	1.15	8.0	3.5	1.75	2.0	4.0	Φ1.5



4. Packing method

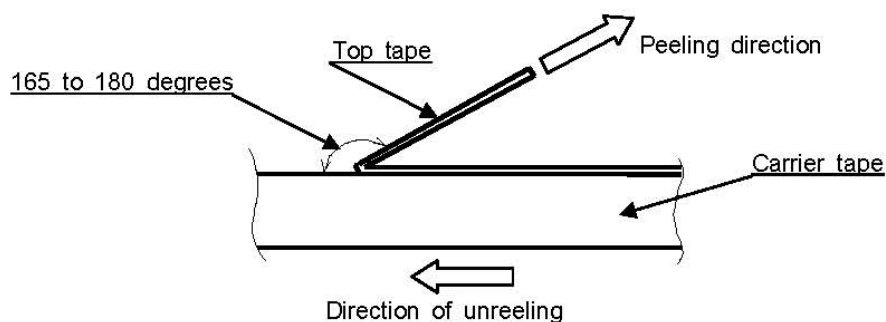
(1) Details of leader and trailer

- ①The tape will have a empty pocket at the leader and trailer of carrier tape.
- ②The tape end will not be stucked by glue in order to make it easier to peel off from reel.
- ③The feeding round hole will be on the right side against t leading direction.



(2) Heat pressure tape

- ①Peeling strength to be 0.1~0.7N when peeling off the top tape by following method.
- ②When peeling top tape off, the glue will be stuck to the top tape side.
- ③Chip capacitor will not stuck on heat pressure tape and will be free in the cavity.



The peel-off angle:165~180 degree against the surface of carrier tape.
The peel-off speed:300mm/min.

(3) Carrier tape

- ①Chip will not fall off from carrier tape or carrier tape will not be damaged by bending than within aradius of 25mm.
- ②The chip are inserted continuously without any empty pocket.
- ③Chip will not be mis-mounted because of too big clearance between components and cavity. Also the waste of carrier tape will not fill a nozzle hole of mouting machine.

5. Indication and packing

- ①There will be following indication on one side of the reel: "PART NUMBER", "LOT NUMBER", "QUANTITY", "DATE OF MANUFACTURE", "CUSTOMER'S NAME"
- ②There will be following indication on the reel box: "PART NUMBER", "LOT NUMBER", "QUANTITY OF REEL", "DATE OF MANUFACTURE", "CUSTOMER'S NAME"
- ③We adequately pack the box to prevent chip capacitor from any mechanical damage during transportation.

Precautions

■ Handling

- 1) Cracks may occur unless otherwise avoiding excessive stress to the capacitors by the load of an adsorption nozzle, and bending of a substrate at the time of mounting.
- 2) Please arrange the capacitor position where they don't have too much stress of board bending after mounting.
- 3) Please design that the form and size of the land pattern has suitable solder amount.
Otherwise cracks may occur. The recommended fillet height shall be 1/2 to 1/3 of the thickness of capacitors.

■ Circuit Design

- 1) When AC voltage is superimposed on DC voltage, the zero-to-peak voltage shall not exceed the rated voltage. When the capacitor is to be employed in a circuit in which there is continuous application of a high frequency Voltage or a steep pulse voltage, even though it is within the rated voltage, please inquire to the manufacturer.
- 2) Please use the capacitor below the maximum temperature.
When using the capacitor in a self-heating AC circuit, please make sure the surface of the capacitor remains under the maximum temperature for usage. Also, please make certain temperature rises remain below 20 °C.

■ Resin coating

Please use the resin of low curing shrinkage type. (Otherwise cracks may occur).

■ Storage

- 1) When the components is stored in minimal packaging (a heat-sealed or chuck-type plastic bag), the bag should be kept closed. Once the bag has been opened, reseal it or store it in a desiccator.
- 2) Keep storage place temperature +5 to +40 °C, humidity 20 to 70% RH.
- 3) The storage atmosphere must be free of gas containing sulfur and chlorine. Also, avoid exposing the product to saline moisture. If the product is exposed to such atmospheres, the terminals will oxidize and solderability will be effected.
- 4) Precautions 1) to 3) apply to chip capacitors packaged in carrier tapes and bulk cases.
- 5) The solderability is assured for 6 months from our shipping date if the above storage precautions are followed.

■ Application Restriction

Please consult with us before using a capacitor in the equipment which requires a high degree reliability (medical equipment, aerospace applications, nuclear equipment.) Malfunctions in medical, space, nuclear power or other vital equipment may result in death or great social losses. Capacitors designed specially with high reliability are used for the equipment above.

■ Export regulation

When the applying products relate the strategic materials which are provided in Foreign Exchange and Foreign Trade Act and Foreign Trade Management Law, the export license based on these laws are required.

■ Disposal

Please dispose the capacitors according to the relating laws about the waste treatment and cleaning. Safety application guideline and detailed information of electrical properties are also provided in Kyocera home page:

URL: <http://www.kyocera.co.jp/electronic>

Notice:

This specification shall guarantee only monolithic capacitors. Please make sure the performance of capacitors after mounted on the assembled product.

Any failures occurred being used out of this specification shall not be guaranteed.

This specification shall be applied to the products purchased through the regular sales routes, such as the sale offices, the subsidiaries and the distributors, etc.).



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[>>Kyocera\(京瓷\)](#)